

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10517948	HEISE ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Chen, Xiaoliang	2841

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
361	104, 760-763, 833, 834	05-17-07	xc
174	250, 261	05-17-07	xc
337	227, 290-297	05-17-07	xc
361	104, 760-763, 833, 834	05-23-08	xc
174	250, 261	05-23-08	xc

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Puls, Inventor,	05-16-07	xc
EAST / Ref Proir Art, Foreward/Backward, USPAT, PGPUB, DERWENT, IBM-TDB, ITIC-On line, IEEE Xplore and text	05-16-07	xc
Consulted Tuan Dinh	05-16-07	xc
Updated East Serach	10-03-07	xc
Updated East Search	1-22-08	xc
East Search	05-23-08	xc

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>